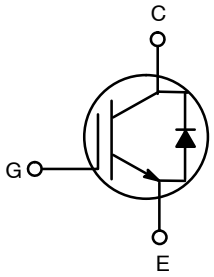
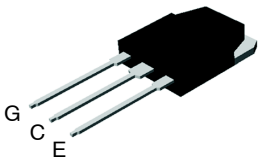
IGBT – Field Stop

650 V, 60 A

FGA60N65SMD





TO−3P−3LD / EIAJ SC−65, ISOLATED
CASE 340BZ

General Description

Using Novel Field Stop IGBT Technology, **onsemi**'s new series of Field Stop IGBTs offer the optimum performance for Solar Inverter, UPS, SMPS, Welder and PFC applications where low conduction and switching losses are essential.

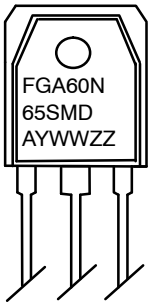
Features

- Maximum Junction Temperature: T_J = 175°C
- Positive Temperature Co−efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(sat)}$ = 1.9 V(Typ.) @ I_C = 60 A
- Fast Switching: E_{OFF} = 7.5 μJ/A
- Tighten Parameter Distribution
- This Device is Pb−Free and is RoHS Compliant

Applications

- Solar Inverter, UPS, SMPS, Welder, PFC

MARKING DIAGRAM



FGA60N65SMD = Specific Device Code
A = Assembly Location
YWW = Date Code (Year & Work Week)
ZZ = Lot Code

ABSOLUTE MAXIMUM RATINGS

Symbol	Rating		Value	Unit
V_{CES}	Collector to Emitter Voltage		650	V
V_{GES}	Gate to Emitter Voltage		±20	V
	Transient Gate to Emitter Voltage		±30	V
I_C	Collector Current	T_C = 25°C	120	A
		T_C = 100°C	60	A
I_{CM}	Pulsed Collector Current (Note 1)		180	A
I_F	Diode Forward Current	T_C = 25°C	60	A
		T_C = 100°C	30	A
I_{FM}	Pulsed Diode Maximum Forward Current (Note 1)		180	A
P_D	Maximum Power Dissipation	T_C = 25°C	600	W
		T_C = 100°C	300	W
T_J	Operating Junction Temperature		−55 to +175	°C
T_{stg}	Storage Temperature Range		−55 to +175	°C
T_L	Maximum Lead Temp. for Soldering Purposes, 1/8" from Case for 5 Seconds		300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
1. Repetitive rating: Pulse width limited by max. junction temperature

ORDERING INFORMATION

Device	Package	Shipping
FGA60N65SMD	TO−3P−3L	450 / Box

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THERMAL CHARACTERISTICS

Symbol	Characteristic	Value	Unit
$R_{\theta JC}$(IGBT)	Thermal Resistance, Junction to Case	0.25	°C/W
$R_{\theta JC}$(Diode)	Thermal Resistance, Junction to Case	1.1	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	40	°C/W

ELECTRICAL CHARACTERISTICS OF THE IGBT (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
OFF CHARACTERISTICS						
BV_{CES}	Collector to Emitter Breakdown Voltage	V_{GE} = 0 V, I_C = 250 μA	650	–	–	V
$\frac{\Delta BV_{CES}}{\Delta T_J}$	Temperature Coefficient of Breakdown Voltage	V_{GE} = 0 V, I_C = 250 μA	–	0.6	–	V/°C
I_{CES}	Collector Cut−Off Current	V_{CE} = V_{CES}, V_{GE} = 0 V	–	–	250	μA
I_{GES}	G−E Leakage Current	V_{GE} = V_{GES}, V_{CE} = 0 V	–	–	±400	nA
ON CHARACTERISTICS						
$V_{GE(th)}$	G−E Threshold Voltage	I_C = 250 μA, V_{CE} = V_{GE}	3.5	4.5	6.0	V
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	I_C = 60 A, V_{GE} = 15 V	–	1.9	2.5	V
		I_C = 60 A, V_{GE} = 15 V, T_C = 175°C	–	2.1	–	V
DYNAMIC CHARACTERISTICS						
C_{ies}	Input Capacitance	V_{CE} = 30 V, V_{GE} = 0 V, f = 1 MHz	–	2915	–	pF
C_{oes}	Output Capacitance		–	270	–	pF
C_{res}	Reverse Transfer Capacitance		–	85	–	pF
SWITCHING CHARACTERISTICS						
$t_{d(on)}$	Turn-On Delay Time	V_{CC} = 400 V, I_C = 60 A, V_{GE} = 15 V, R_G = 3 Ω, Inductive Load, T_C = 25°C	–	18	27	ns
t_r	Rise Time		–	47	70	ns
$t_{d(off)}$	Turn-Off Delay Time		–	104	146	ns
t_f	Fall Time		–	50	68	ns
E_{on}	Turn−On Switching Loss		–	1.54	2.31	mJ
E_{off}	Turn−Off Switching Loss		–	0.45	0.60	mJ
E_{ts}	Total Switching Loss		–	1.99	2.91	mJ
$t_{d(on)}$	Turn-On Delay Time	V_{CC} = 400 V, I_C = 60 A, V_{GE} = 15 V, R_G = 3 Ω, Inductive Load, T_C = 175°C	–	18	–	ns
t_r	Rise Time		–	41	–	ns
$t_{d(off)}$	Turn-Off Delay Time		–	115	–	ns
t_f	Fall Time		–	48	–	ns
E_{on}	Turn−On Switching Loss		–	2.08	–	mJ
E_{off}	Turn−Off Switching Loss		–	0.78	–	mJ
E_{ts}	Total Switching Loss		–	2.86	–	mJ
Q_g	Total Gate Charge	V_{CE} = 400 V, I_C = 60 A, V_{GE} = 15 V	–	189	284	nC
Q_{ge}	Gate to Emitter Charge		–	20	30	nC
Q_{gc}	Gate to Collector Charge		–	91	137	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ELECTRICAL CHARACTERISTICS OF THE DIODE (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition		Min.	Typ.	Max.	Unit
V_{FM}	Diode Forward Voltage	I_F = 30 A	T_C = 25°C	–	2.1	2.6	V
			T_C = 175°C	–	1.7	–	
E_{rec}	Reverse Recovery Energy	I_F = 30 A, dI_F/dt = 200 A/μs	T_C = 175°C	–	127	–	μJ
t_{rr}	Diode Reverse Recovery Time		T_C = 25°C	–	47	–	ns
			T_C = 175°C	–	212	–	
Q_{rr}	Diode Reverse Recovery Charge		T_C = 25°C	–	87	–	nC
			T_C = 175°C	–	933	–	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL PERFORMANCE CHARACTERISTICS

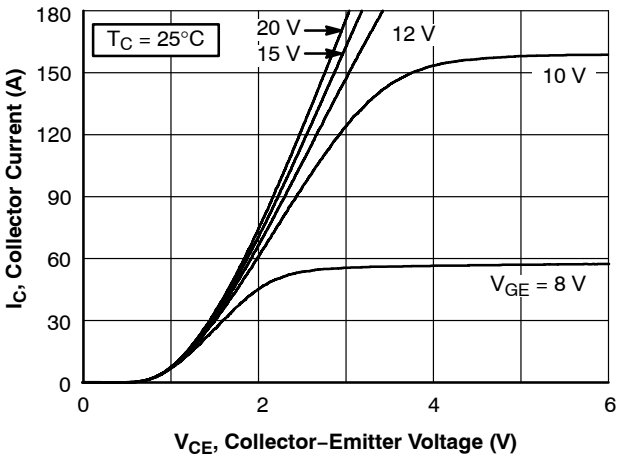

Figure 1. Typical Output Characteristics

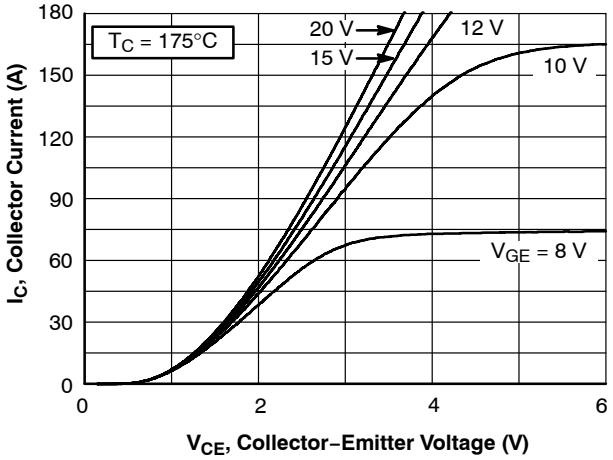

Figure 2. Typical Output Characteristics

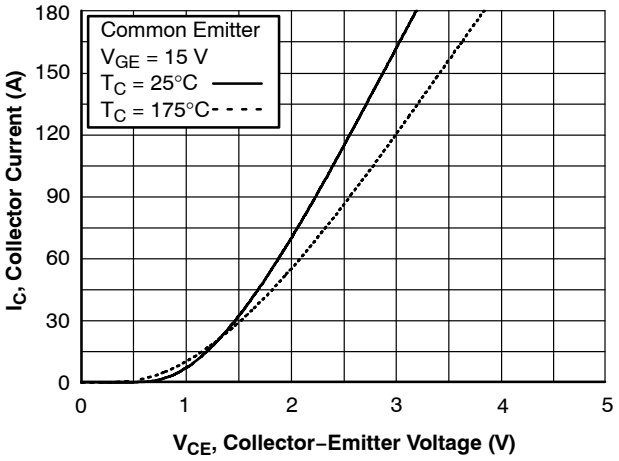

Figure 3. Typical Saturation Voltage Characteristics

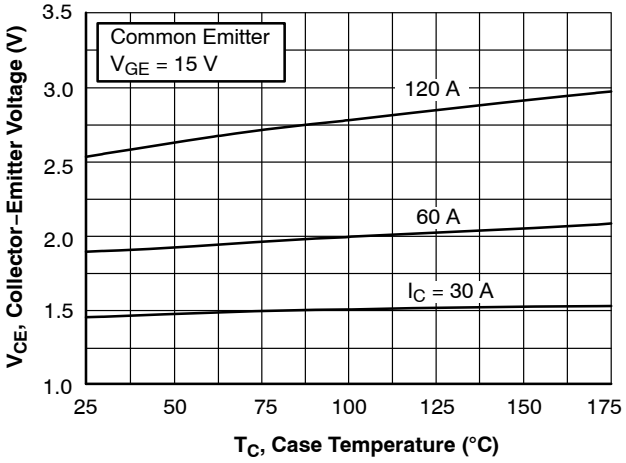

Figure 4. Saturation Voltage vs. Case Temperature at Variant Current Level

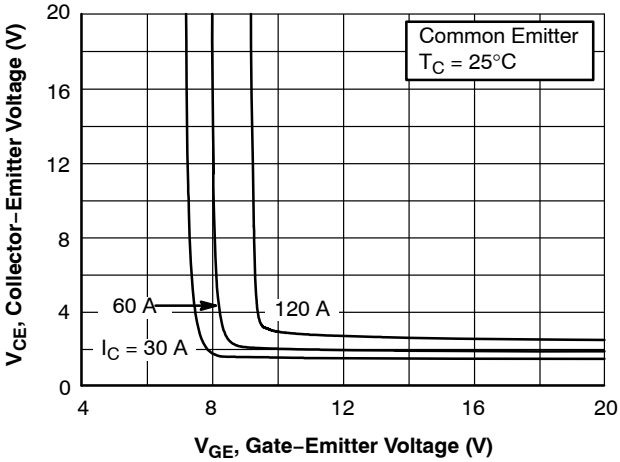

Figure 5. Saturation Voltage vs. V_{GE}

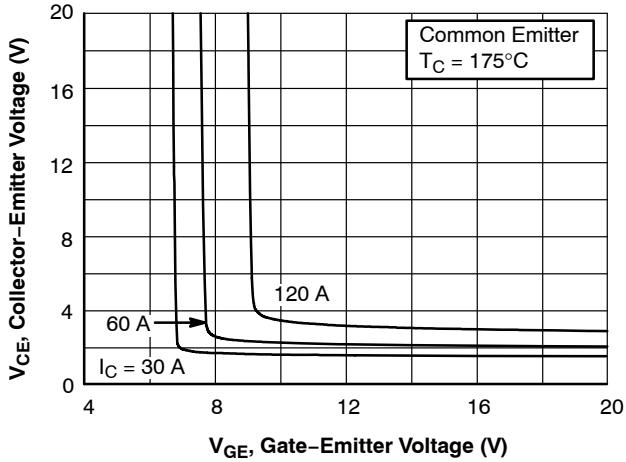

Figure 6. Saturation Voltage vs. V_{GE}

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

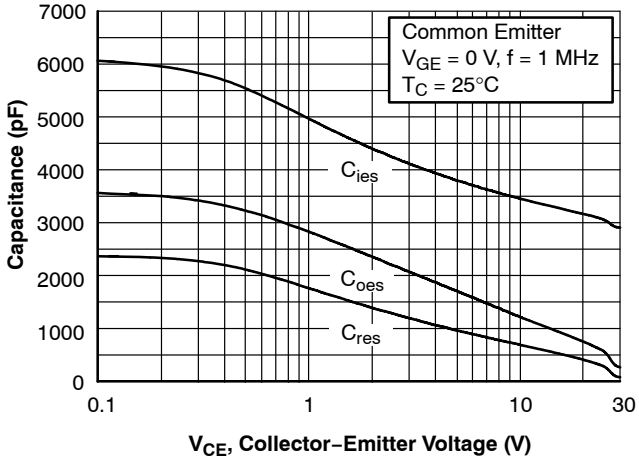

Figure 7. Capacitance Characteristics

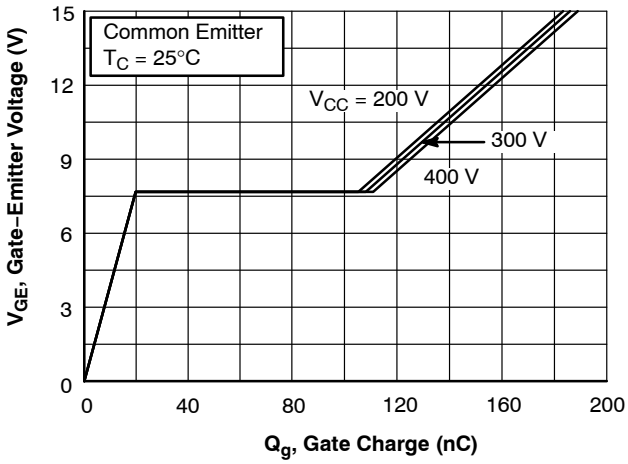

Figure 8. Gate Charge Characteristics

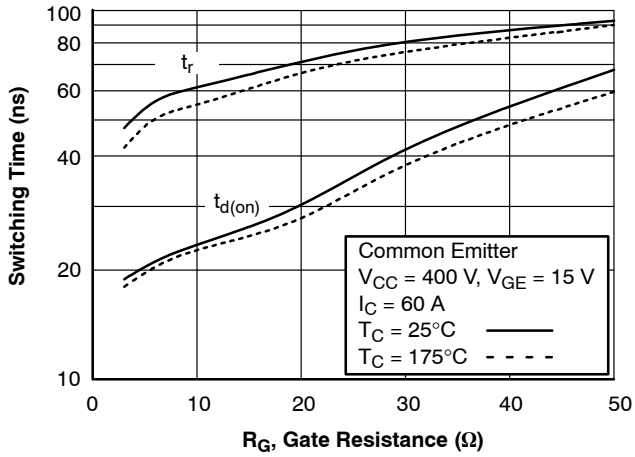

Figure 9. Turn−on Characteristics vs. Gate Resistance

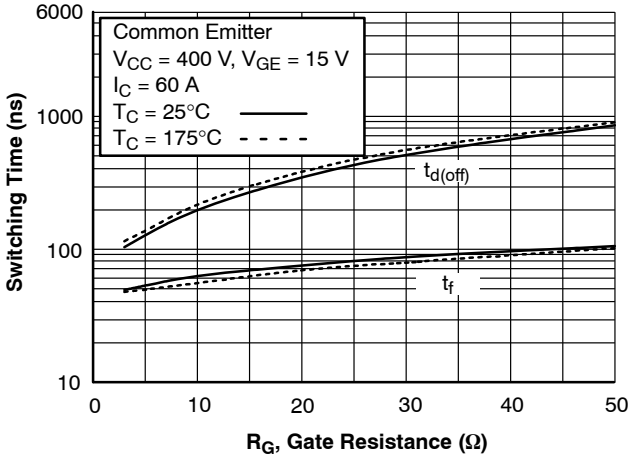

Figure 10. Turn−off Characteristics vs. Gate Resistance

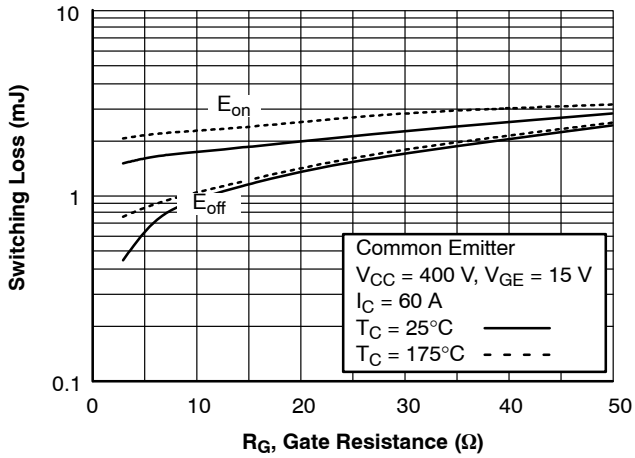

Figure 11. Switching Loss vs. Gate Resistance

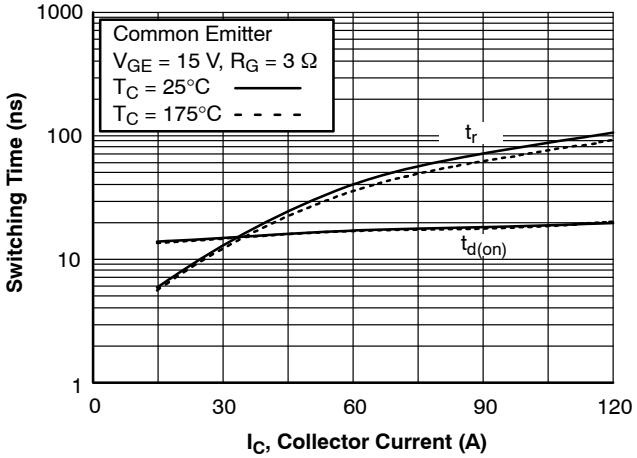

Figure 12. Turn−on Characteristics vs. Collector Current

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

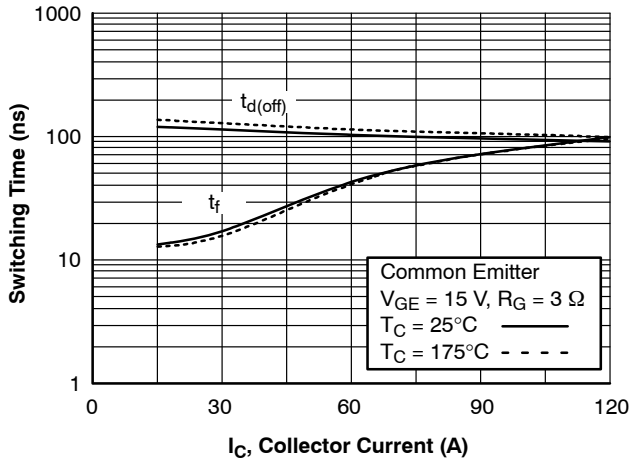

Figure 13. Turn−off Characteristics vs. Collector Current

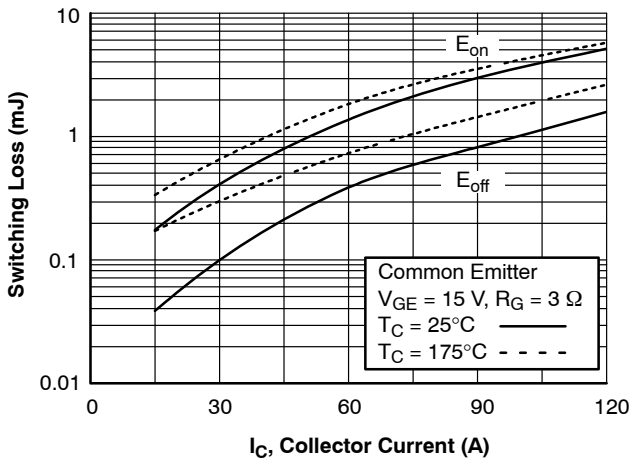

Figure 14. Switching Loss vs. Collector Current

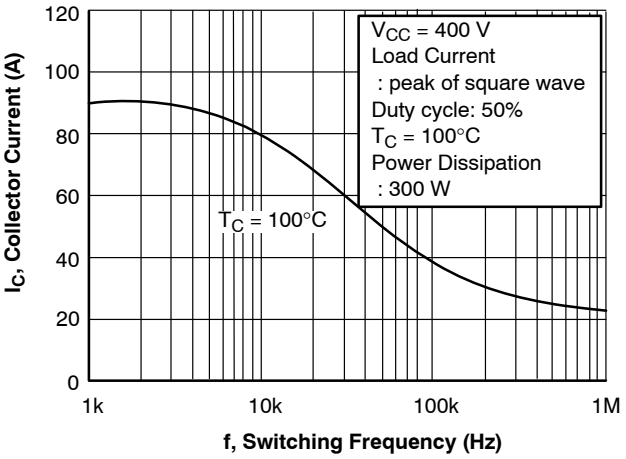

Figure 15. Load Current vs. Frequency

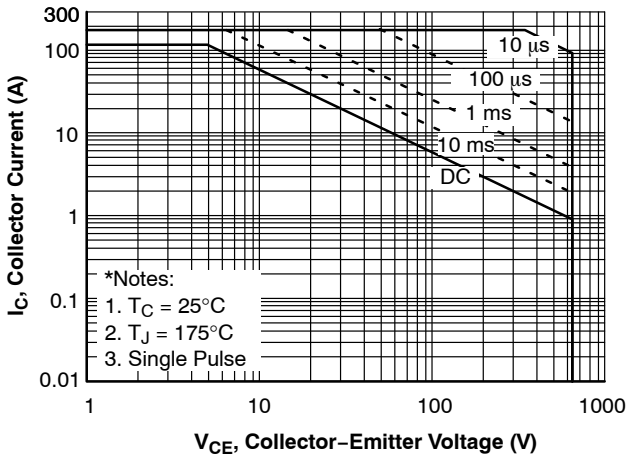

Figure 16. SOA Characteristics

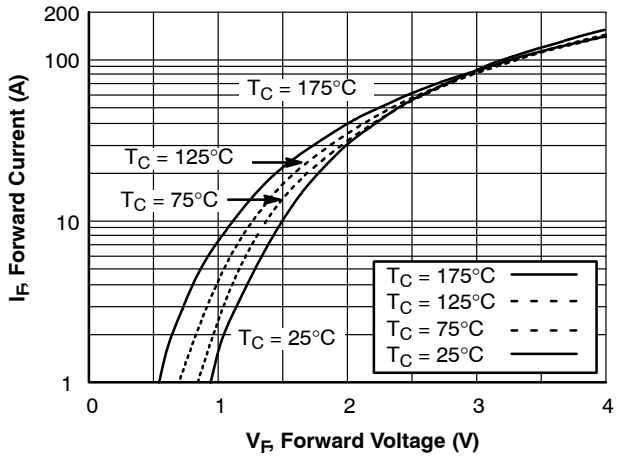

Figure 17. Forward Characteristics

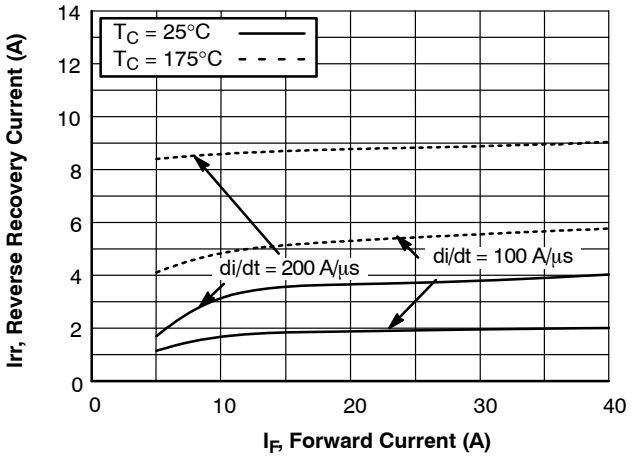

Figure 18. Reverse Recovery Current

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

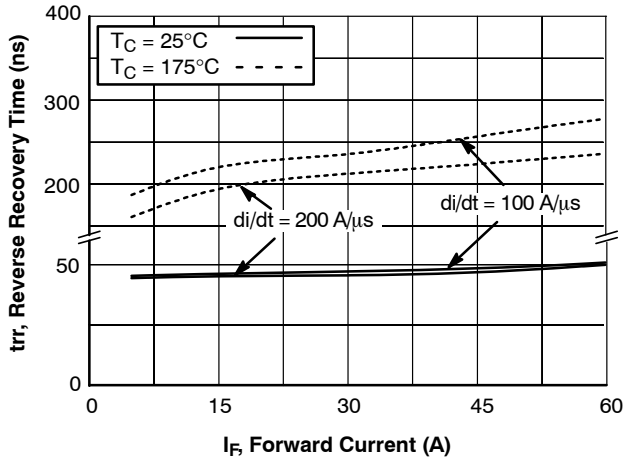

Figure 19. Reverse Recovery Time

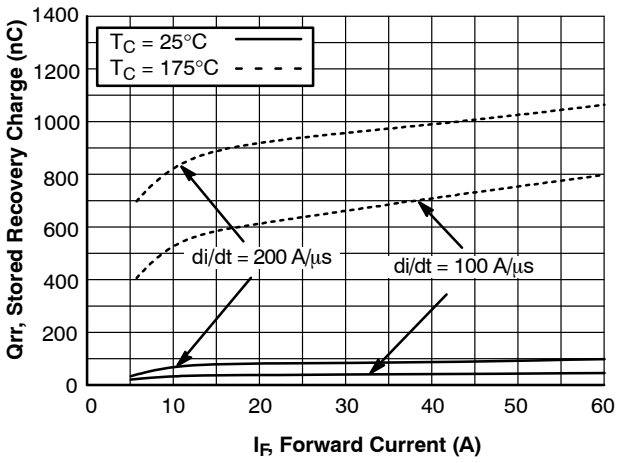

Figure 20. Stored Charge

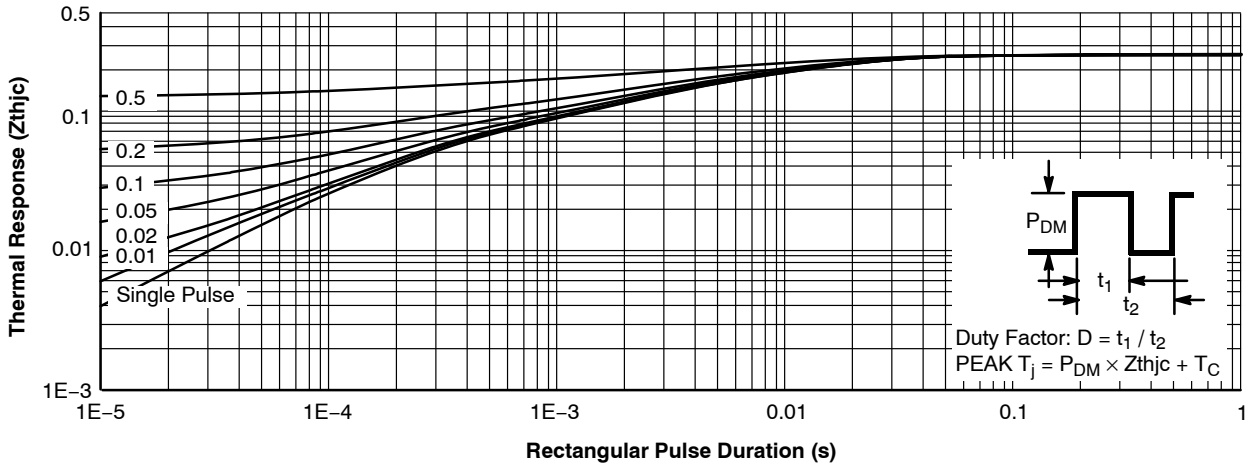

Figure 21. Transient Thermal Impedance of IGBT

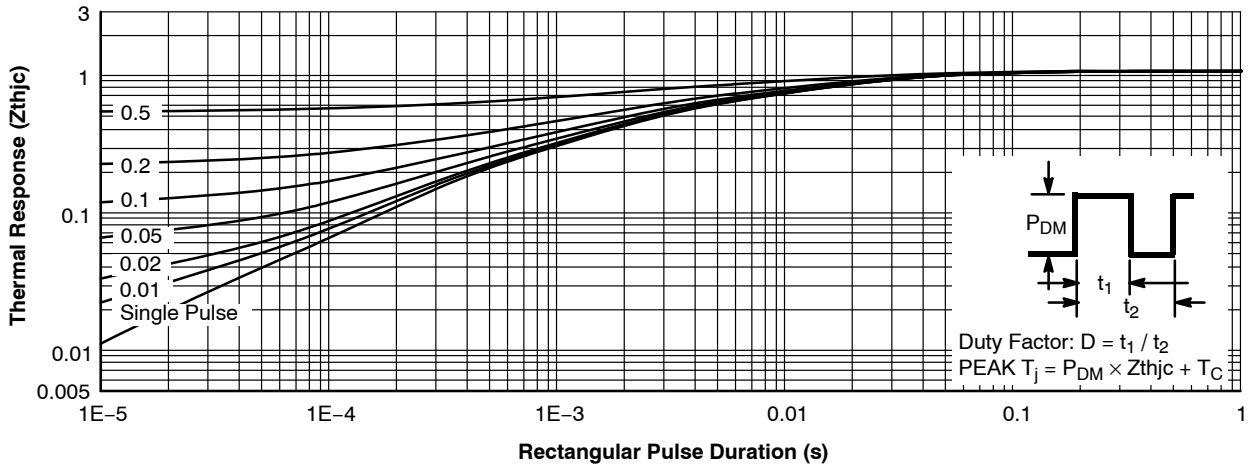

Figure 22. Transient Thermal Impedance of Diode

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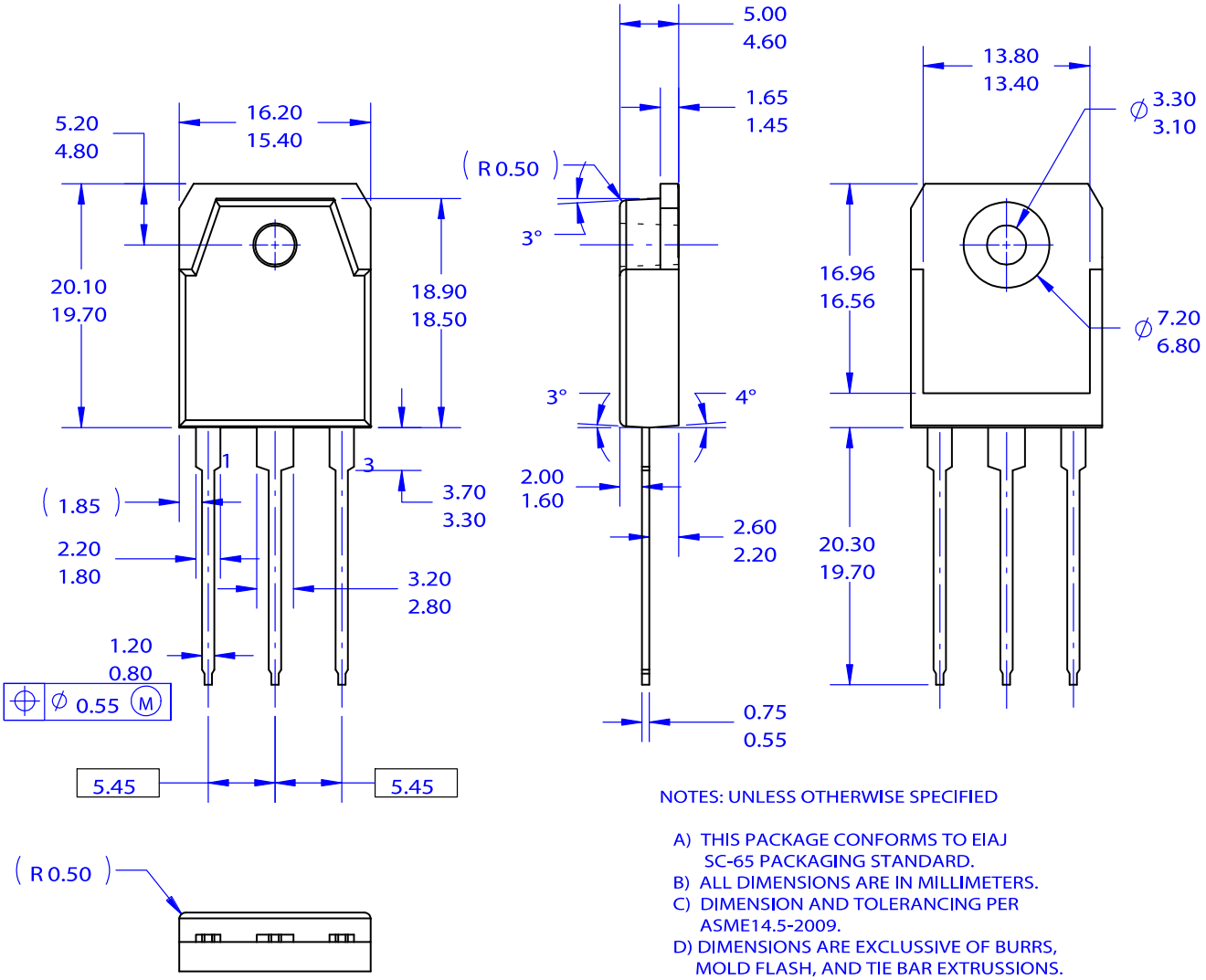
DATE 31 OCT 2016



NOTES: UNLESS OTHERWISE SPECIFIED

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B) ALL DIMENSIONS ARE IN MILLIMETERS.
C) DIMENSION AND TOLERANCING PER ASME14.5-2009.
D) DIMENSIONS ARE EXCLUSSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSSIONS.

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